



# **Study of radiation damaged diamonds at Zeuthen**

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DESY, Zeuthen

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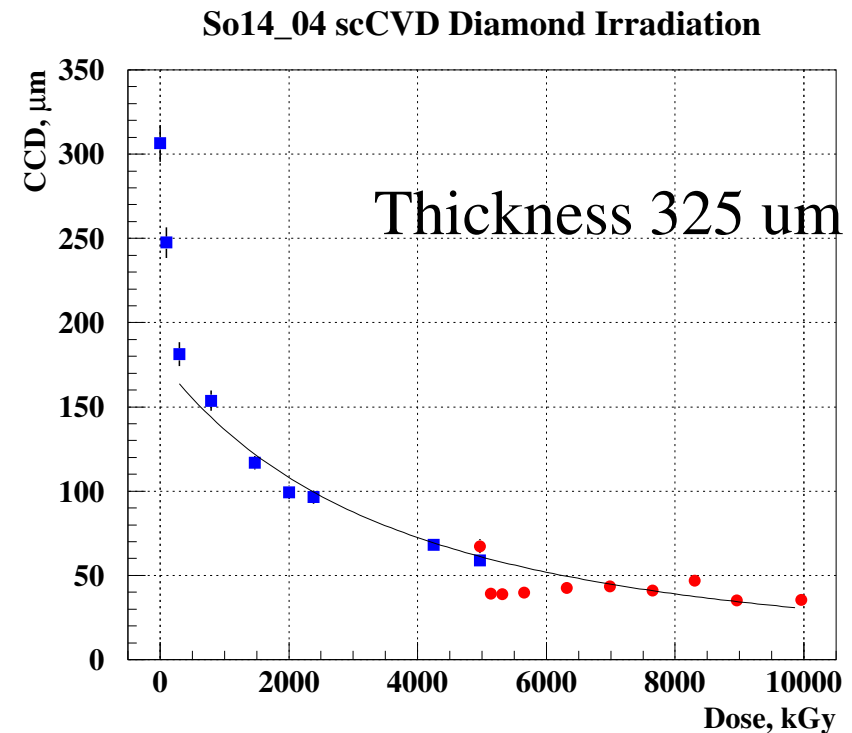


## Diamond detector radiation hardness

Diamond – So14-04, SC CVD by E6, irradiated to 5 MGy @ 2007  
+ 5 MGy more @ 2008 => Total ~10MGy ( $\sim 10^{16}$ ) by 10MeV electrons

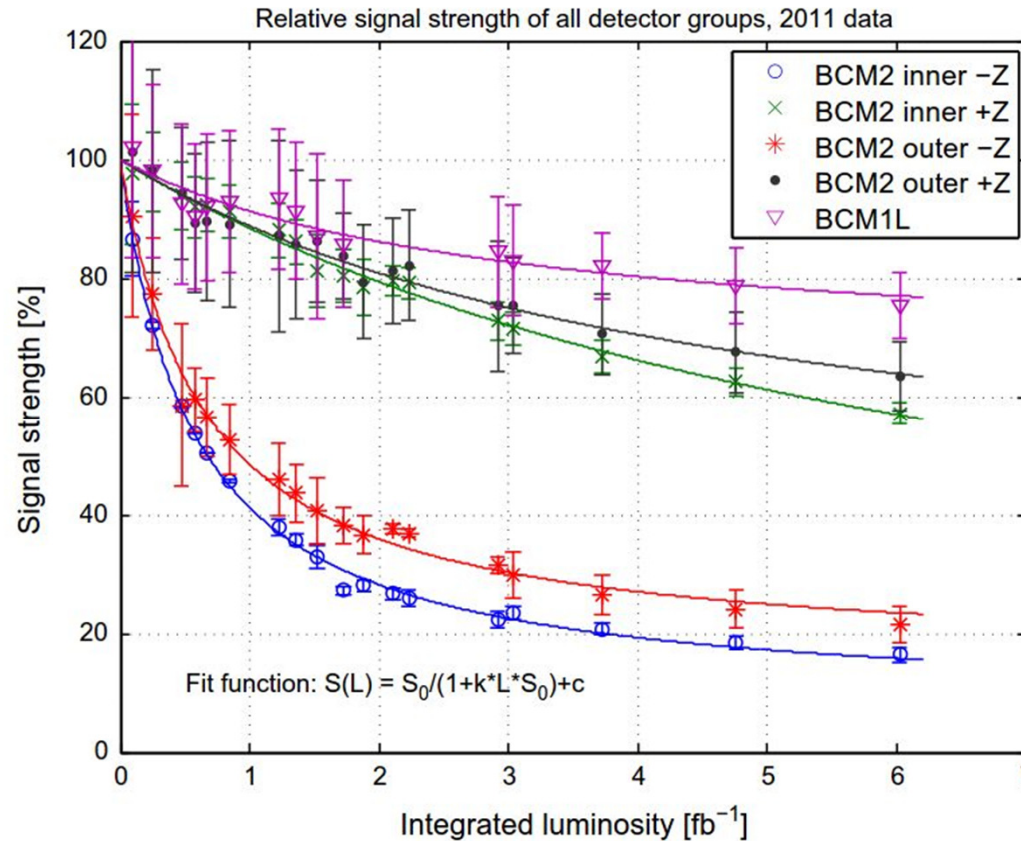
Charge collection efficiency goes  
From 100% to ~ 10%  
MIP signal still visible

10 MGy for diamond roughly  
correspond to  $10^{16}$  n/cm<sup>-2</sup> for Si





# Diamond detector radiation hardness



Hadron fluence (simulations)

$\sim 10^{13}$

$\sim 10^{14}$

Relative (to unirradiated) signal size loss in diamond detectors in CMS luminosity monitor during 2011 run

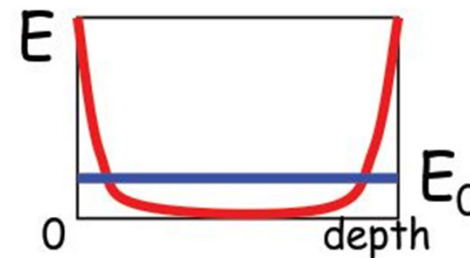
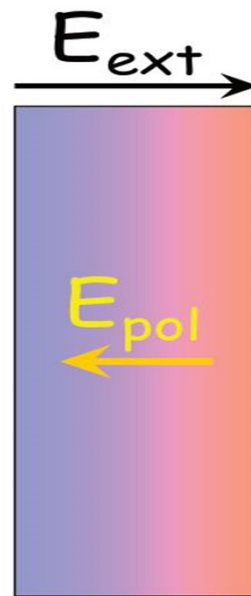
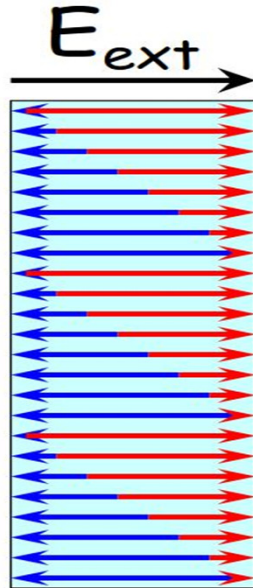


## Why CCE decreases?

Particle knocks atoms out of the crystal lattice – introduces defects

These defects act in two different ways in diamond.

1. Act as a charge carrier traps => reduce collected charge directly.
2. Polarisation: If the charge carrier trapping is not homogeneous => spatial charge => internal field => reduction of effective collecting field => reduce collected charge.

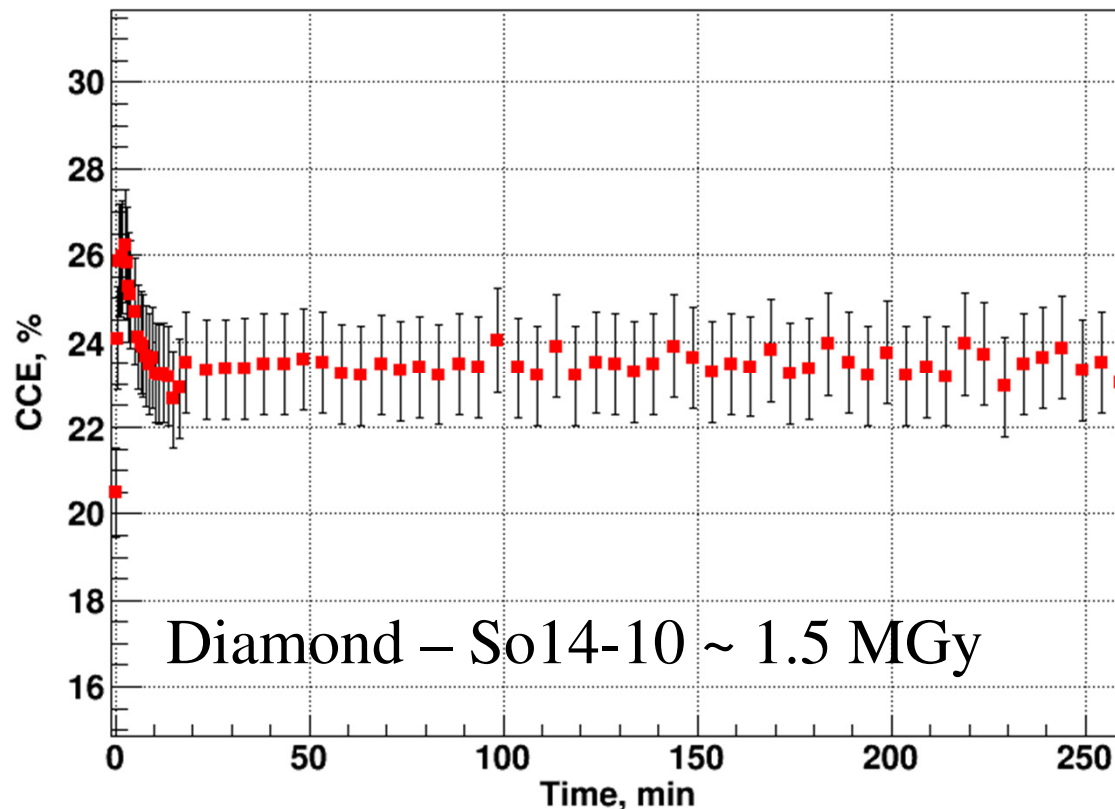




## Typical CCE over time for damaged diamond

Diamond was “reset” by UV lamp for ~ 20 min before the first measurement. CCE was measured over time. @ 300V

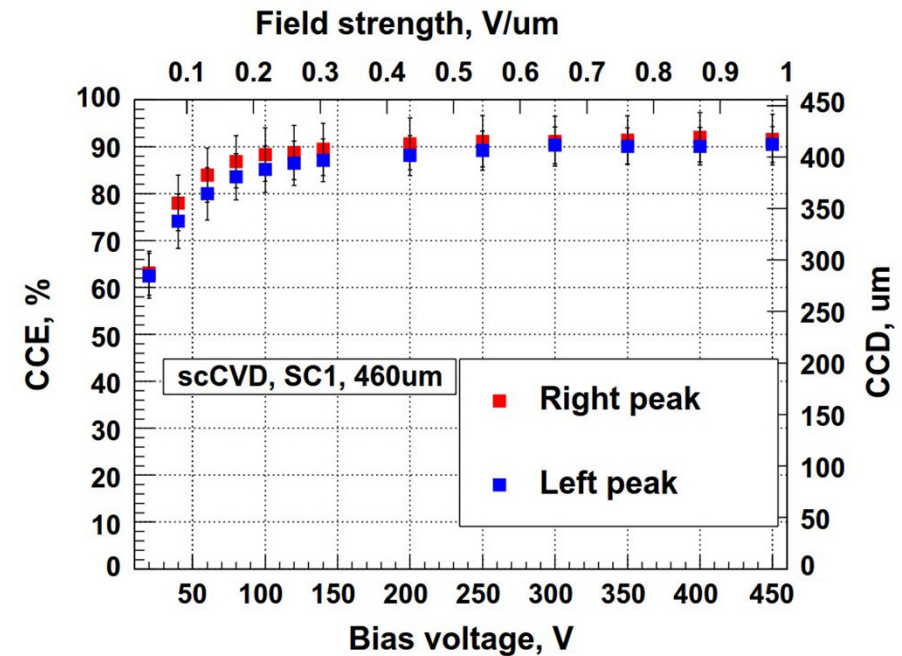
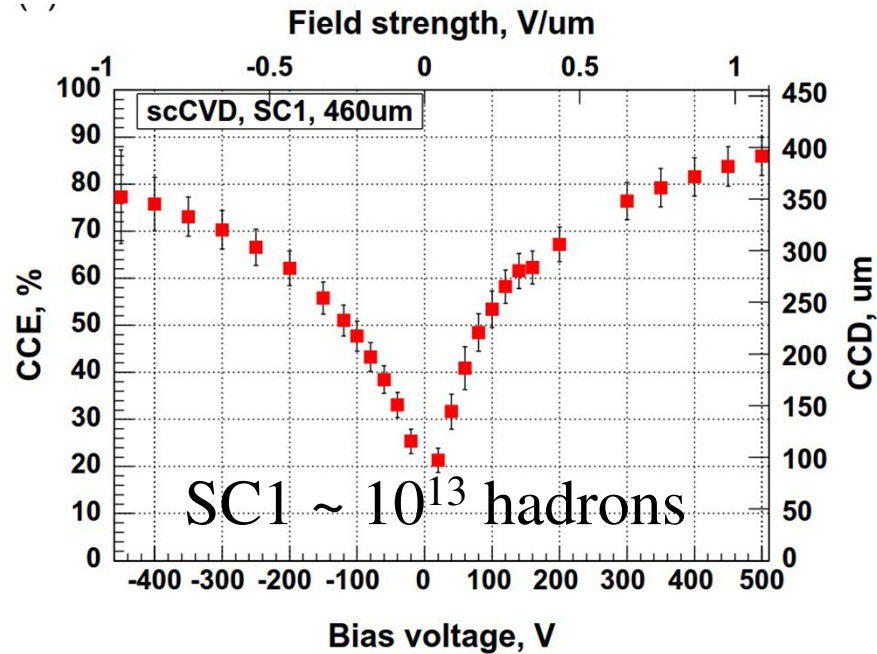
So14-10 325 um



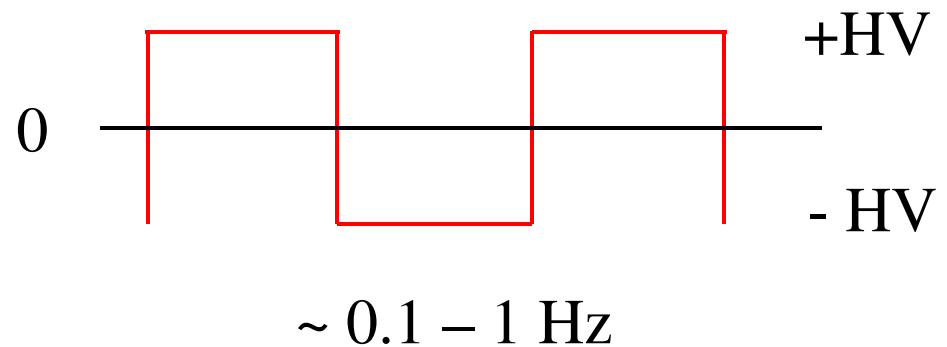
After switching  
on HV and source:  
Fast (few minutes)  
increase in CCE  
Relatively slow  
decrease in CCE  
over next 20-30  
minutes  
Stable signal



## Possible solutions – switched high voltage



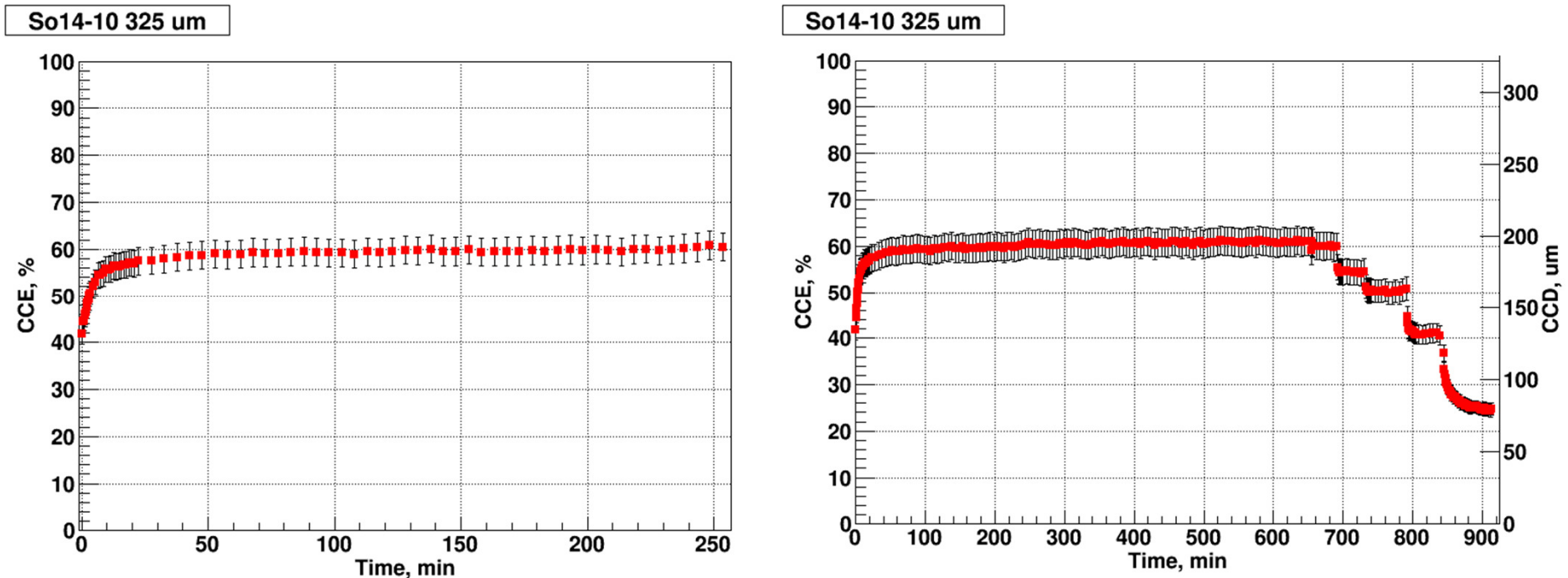
Obvious improvement





## Another possible solution - Illumination

Same process with illumination by red LED (635nm, 1.95eV)



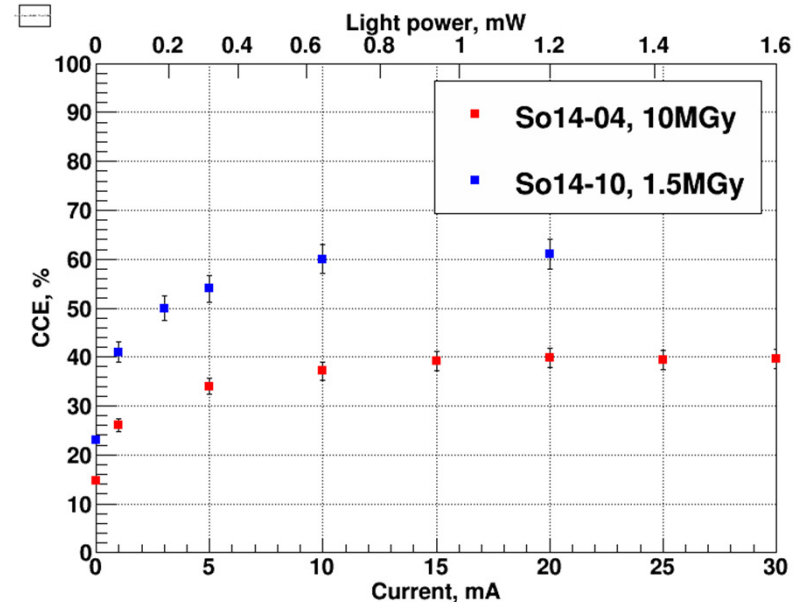
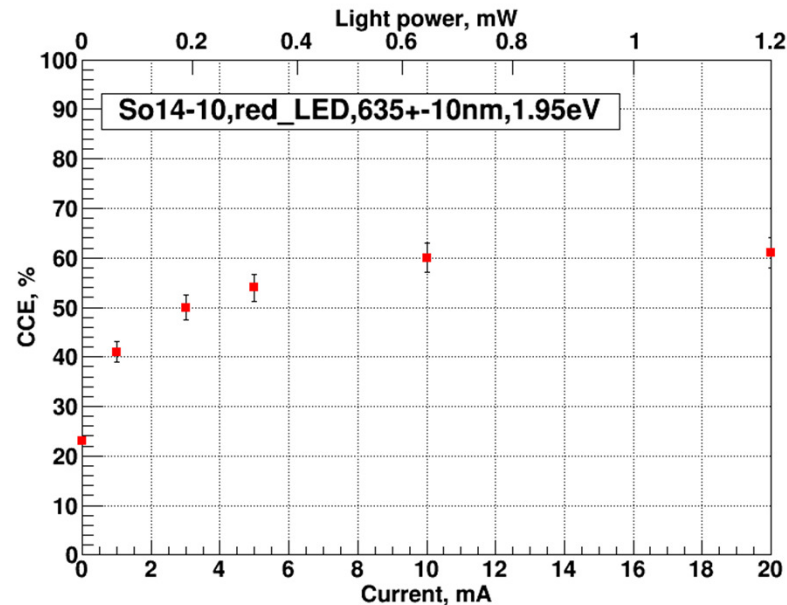
Slow (~20-30 min) increase in CCE to 60% from stable 23%

Stable effect over 10 hours

Steps are testt of different light intensities



# Illumination



Effect depends on the intensity of light

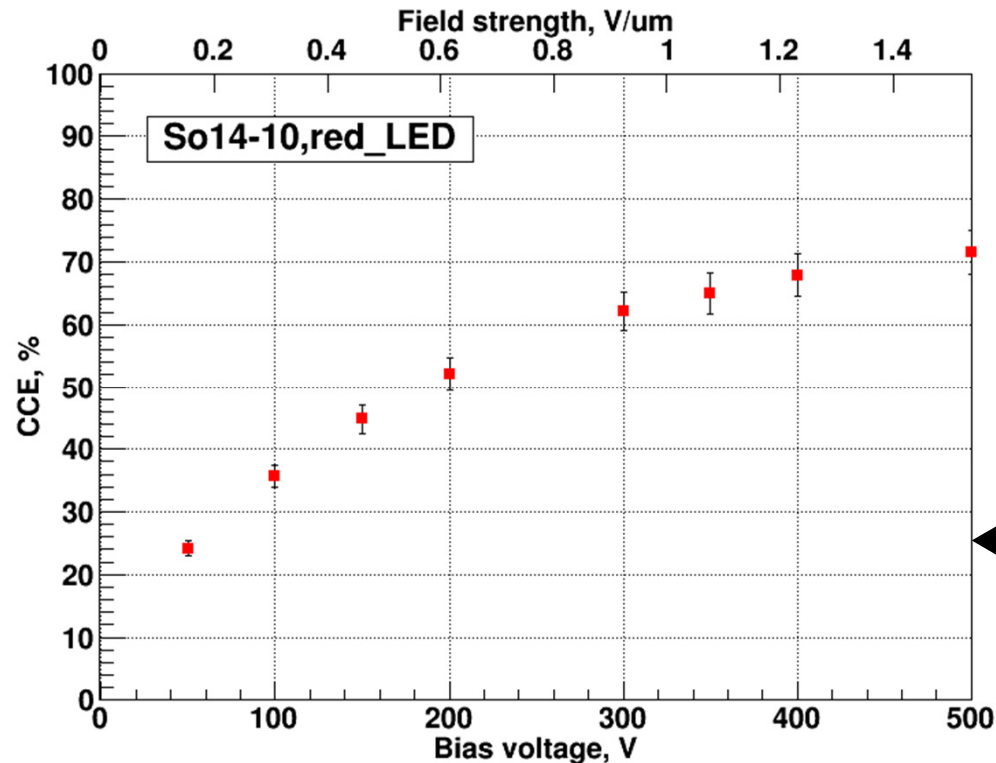
There is a saturated value

Saturation is at similar power for two samples with order of magnitude difference in damage, i.e. does not depend on damage.

Amount of recovered CCE close to 2.5 times “stable” value for both



## CCE vs HV



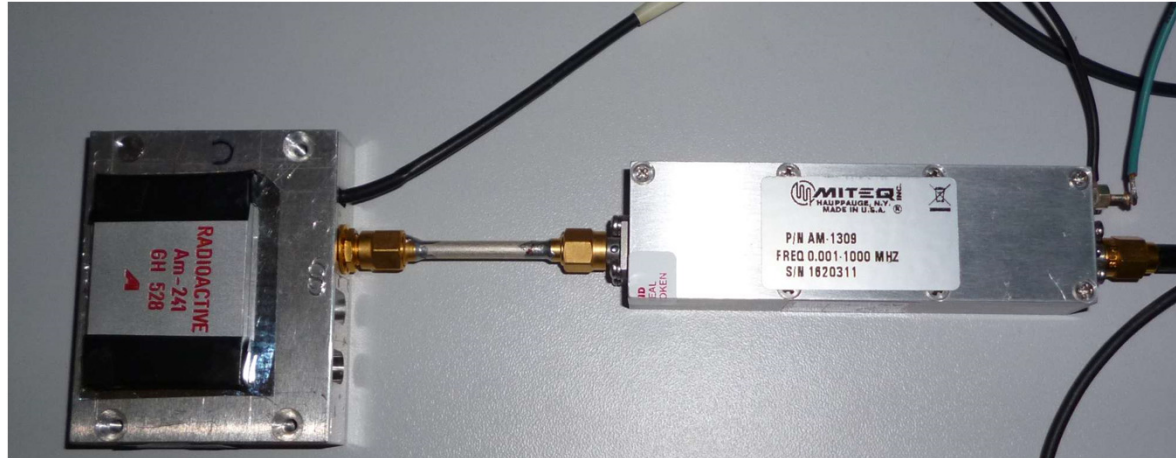
~ 25% CCE saturated  
without illumination



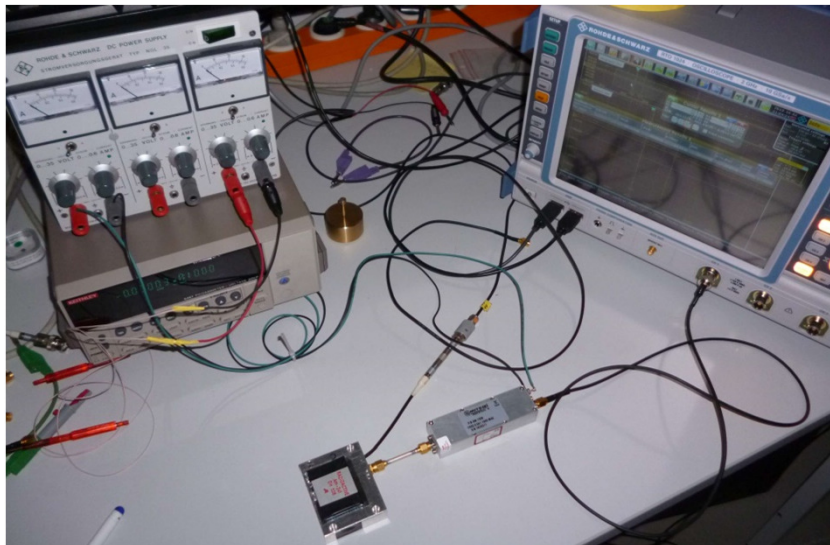
CCE vs HV still looks like it should for damaged diamond – no CCE saturation at low voltages (was ~100% @ 80V before irradiation)



# TCT



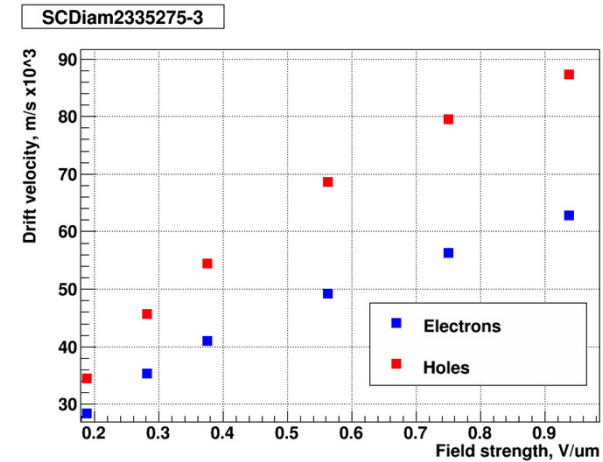
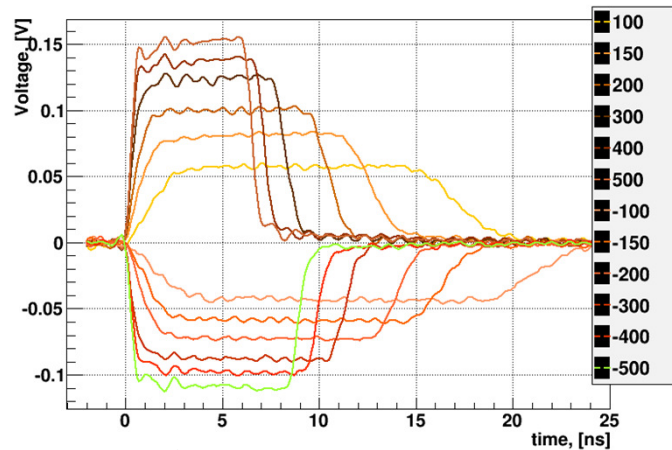
## Transient Current Technique



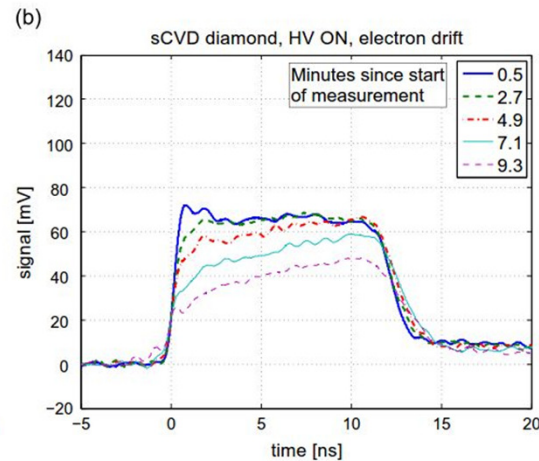
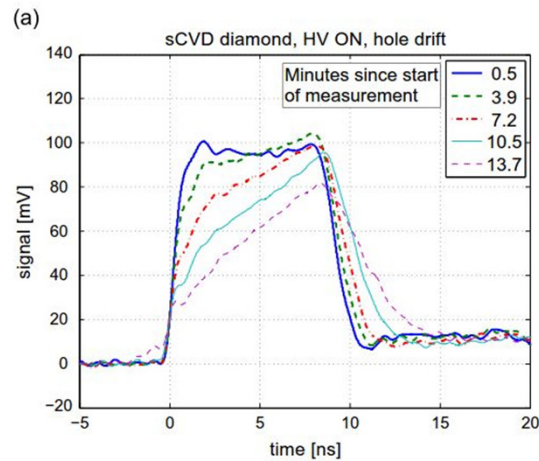
Inject a large amount of charge carriers near the surface and  
Look at the transient current during charge transport in the detector  
Allows to see the difference between electron and hole components  
Allows to measure drift time => drift velocity => mobility  
Allows to see the influence of internal field



# TCT



Results from the current setup – undamaged diamond



What is possible:  
Onset of the polarisation  
field – Moritz Guthoff



## Conclusion

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It is possible to improve CCE of radiation damaged diamond detectors

with both alternating HV (homogeneous space charge) and light illumination (probably preventing formation of strong the space charge).

Both methods show significant improvement in CCE.

Effect of light illumination on CCE depends on light intensity and It is saturated at some light intensity. The saturation value does not depend on damage amount.

Probably will depend on intensity of charge carrier generation (radiation intensity). – going to check this right after the workshop  
TCT setup functional – could be used for research



# Backup

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## Light power

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For comparison purposes only

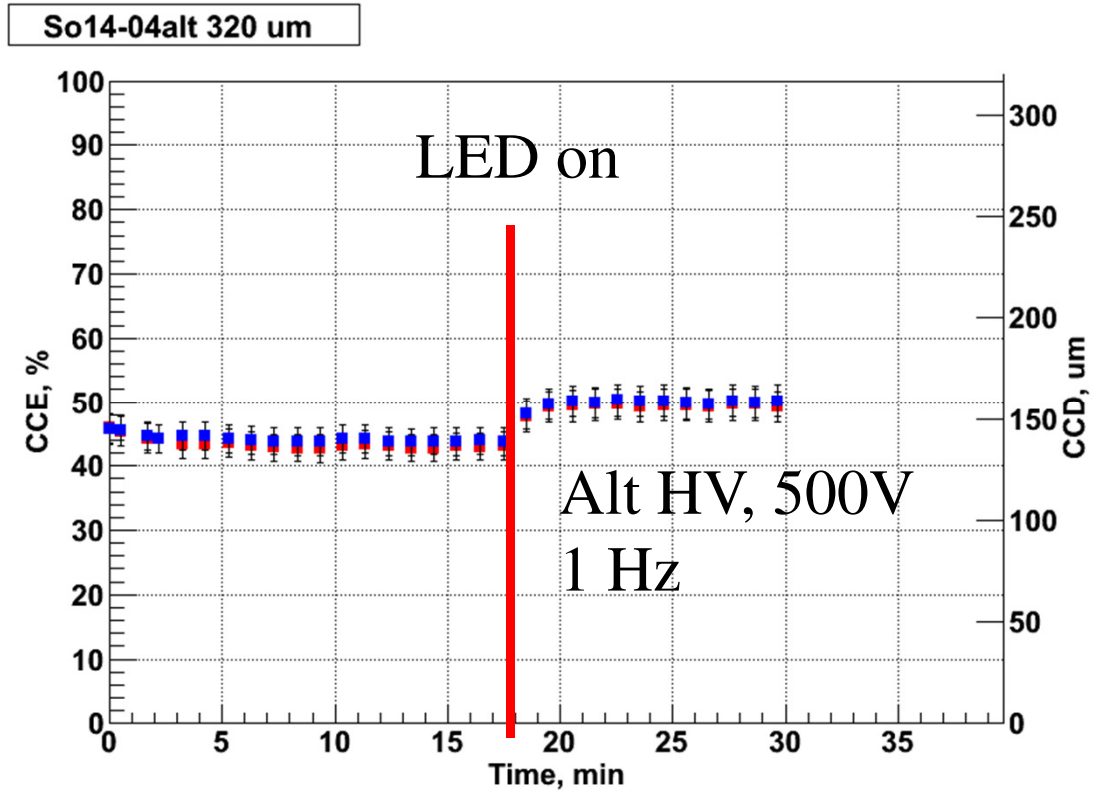
The light power in the LED beam spot was measured by Advatec optical power meter.

I tried to keep the beam spot on diamond under study to the same size for all LEDs. No idea how much of the actual beam power was coupled to the sample.

For comparison, typical light intensity of ambient light in the lab is ~ 100-150  $\mu\text{W}$  for 10x10mm light sensor.



## Light + alt HV



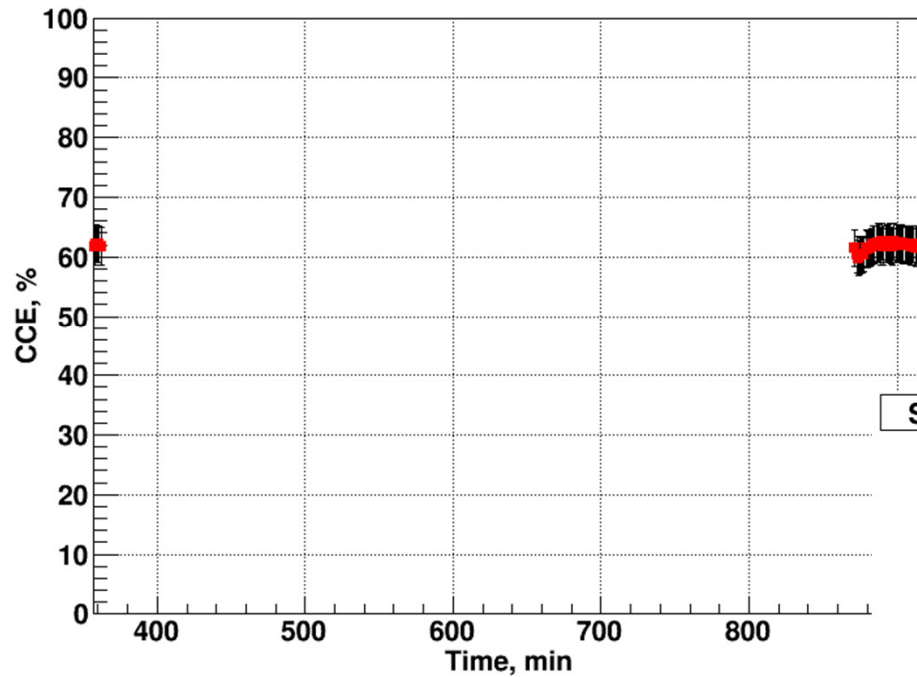
Alt. Voltage + RL is even better.

2013 fast test, not repeated so far

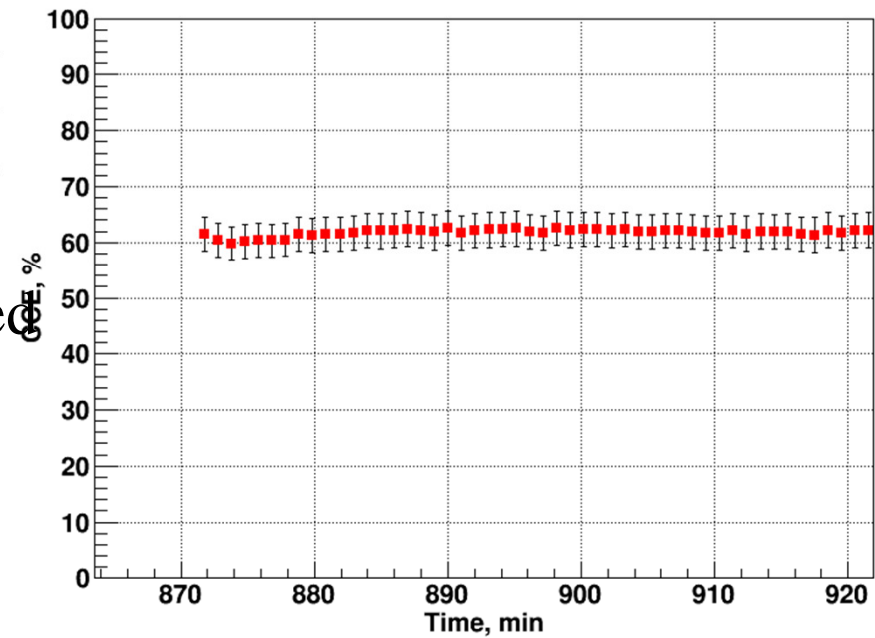


## No source

So14-10 325 um



So14-10 325 um



Stable effect with source removed  
Small transient effect